







Prüfbericht-Nr.: JP231IK4 (P15C-Auftrags-Nr.: Seite 1 von 27 48218304 Order no .: Page 1 of 27 IEEE802.15.4) 001 Test report no.: Kunden-Referenz-Nr.: Auftragsdatum: 2023-04-20 N/A Order date: Client reference no.: KAGA FEI Co., Ltd. Auftraggeber: Gunseisha ANNEX Building 5th floor, 382-1 Kaminamie-machi, Takasaki, Gunma, Client: 370-0801, Japan Prüfgegenstand: Bluetooth low energy/ANT/802.15.4 Module Test item: Bezeichnung / Typ-Nr.: EB5340 Identification / Type no.: Auftrags-Inhalt: FCC Part 15C Test report (IEEE802.15.4) Order content: Prüfgrundlage: Test specification: FCC 47CFR Part 15: Subpart C Section 15.247 Wareneingangsdatum: 2023-04-17 Date of sample receipt: Prüfmuster-Nr.: A003458670-013 Test sample no: A003458670-004 2023-05-19 - 2023-06-14 Prüfzeitraum: Testing period: Ort der Prüfung: **EMC/RF** Taipei Testing Place of testing: Prüflaboratorium: Taipei Testing Laboratories Testing laboratory: Prüfergebnis\*: Pass Test result\*: zusammengestellt von: genehmigt von: compiled by: authorized by: Anderson Clive Ausstellungsdatum: Datum: Date: 2023-06-28 Issue date: 2023-06-28 Anderson Chiu Brenda Chen Stellung / Position: Stellung / Position: Senior Project Manager Senior Project Manager Sonstiges / Other: Zustand des Prüfgegenstandes bei Anlieferung: Prüfmuster vollständig und unbeschädigt Condition of the test item at delivery: Test item complete and undamaged \* Legende: 1 = sehr gut 3 = befriedigend 4 = ausreichend 5 = mangelhaft P(ass) = entspricht o.g. Prüfgrundlage(n) F(ail) = entspricht nicht o.g. Prüfgrundlage(n) N/T = nicht getestet N/A = nicht anwendbar 3 = satisfactory 5 = poor 1 = very good 2 = good4 = sufficient \* Leaend: F(ail) = failed a.m. test specification(s) N/T = not testedP(ass) = passed a.m. test specification(s) N/A = not applicable

Dieser Prüfbericht bezieht sich nur auf das o.g. Prüfmuster und darf ohne Genehmigung der Prüfstelle nicht auszugsweise vervielfältigt werden. Dieser Bericht berechtigt nicht zur Verwendung eines Prüfzeichens.

This test report only relates to the a. m. test sample. Without permission of the test center this test report is not permitted to be duplicated in extracts. This test report does not entitle to carry any test mark.



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## **TEST SUMMARY**

Report Section	FCC Clause	Test Item	Result
5.1.1	15.247(b) & 15.203	Antenna Requirement	Pass
5.1.2	15.247(b)(3)	Peak Output Power	Pass
5.1.3	15.247(a)(2)	6 dB Bandwidth	Pass
5.1.3	2.1049	99% Occupied Bandwidth	Pass
5.1.4	15.247(e)	Power Spectral Density	Pass
5.1.5	15.247(d)	Conducted Spurious Emissions and Band Edges	Pass
5.1.6	15.247(d) & 15.205 & 15.209	Radiated Spurious Emissions and Band Edges	Pass
5.2.1	15.207	Mains Conducted Emission	Pass

**Note:** Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.



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5.1.0		
<b>5.2</b> 5.2.	MAINS EMISSION	



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APPENDIX A - TEST RES	SULT OF CONDUCTED					
APPENDIX B - TEST RES	APPENDIX B - TEST RESULT OF RADIATED EMISSIONS & MAINS CONDUCTED EMISSION					
APPENDIX SP - PHOTOG	GRAPHS OF TEST SETUP					
APPENDIX EP - PHOTOG	GRAPHS OF EUT					



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### **HISTORY OF THIS TEST REPORT**

Report No.	Description	Date Issued
JP231IK4 (P15C- IEEE802.15.4) 001	Original Release	2023-06-28



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## 1. General Remarks

## 1.1 Complementary Materials

All attachments are integral parts of this test report. This applies especially to the following appendix:

Appendix A - Test Result of Conducted

Appendix B - Test Result of Radiated Emissions & Mains Conducted Emission

Appendix SP - Photographs of Test Setup

Appendix EP - Photographs of EUT

### **Applied Standard and Test Levels**

#### Radio

FCC 47CFR Part 15: Subpart C Section 15.247 FCC 47CFR Part 2: Subpart J Section 2.1049

ANSI C63.10:2013

KDB 558074 D01 15.247 Meas Guidance v05r02

## 1.2 Decision Rule of Conformity

The decision rule of conformity of this test report is following the requirements of the requested standard in the quotation, and agreed among testing laboratory and manufacturer (applicant) to exclude the consideration of Measurement Uncertainty, unless it is required by the specific standard.



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## 2. Test Sites

## 2.1 Test Laboratory

Taipei Testing Laboratories

11F. No.758, Sec. 4, Bade Rd., Songshan Dist. Taipei City 105
Taiwan (R.O.C.)

## 2.2 Test Facility

Taipei Testing Laboratories

No.458-18, Sec. 2, Fenliao Rd., Linkou Dist.,

New Taipei City 244 Taiwan (R.O.C.)

FCC Registration No.: 180491 ISED Registration No.: 25563



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## 2.3 Traceability

All measurement equipment calibrations are traceable to NML(Taiwan)/NIST(USA) or where calibration is performed outside Taiwan, to equivalent nationally recognized standards organizations.

### 2.4 Calibration

Equipment requiring calibration is calibrated periodically in a suitably accredited Calibration Lab. Additionally all equipment is verified for proper performance on a regular basics using in house standards or comparisons.

## 2.5 Measurement Uncertainty

All measurement uncertainty values are shown with a coverage factor of k=2 to indicate a 95% level of confidence.

### **Emission Measurement Uncertainty**

Parameter	Uncertainty
Radiated Emission (9 kHz ~ 30 MHz)	± 1.15 dB
Radiated Emission (30 MHz ~ 200 MHz)	± 1.30 dB
Radiated Emission (200 MHz ~ 1 GHz)	± 1.30 dB
Radiated Emission (1 GHz ~ 18 GHz)	± 1.54 dB
Radiated Emission (18 GHz ~ 40 GHz)	± 2.52 dB
Mains Conducted Emission	± 1.65 dB



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## 3. General Product Information

### 3.1 Product Function and Intended Use

The EUT is a Bluetooth low energy/ANT/802.15.4 Module. It contains IEEE802.15.4 compatible module enabling the user to communicate data through a Wireless interface. For details refer to the User Guide, Data Sheet and Circuit Diagram.

## 3.2 System Details and Ratings

#### **Basic Information of EUT**

Item	EUT information
Kind of Equipment/Test Item	Bluetooth low energy/ANT/802.15.4 Module
Type Identification	EB5340
FCC ID	2A6NFEB5340

### **Technical Specification of EUT**

Item	EUT information
Operating Frequency	2405 MHz ~ 2480 MHz
Channel Number	16
Operation Voltage	3 Vdc
Modulation	O-QPSK
Maximum Output Power (mW)	2.12
Antenna Information	Refer to 5.1.1
Accessory Device	Refer to 4.4



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## 3.3 Noise Generating and Noise Suppressing Parts

Refer to the Circuit Diagram.

### 3.4 Submitted Documents

- Circuit Diagram
- Instruction Manual
- Rating Label
- Technical Description



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## 4. Test Set-up and Operation Modes

## 4.1 Principle of Configuration Selection

The test modes were adapted accordingly in reference to the instructions for use.

During testing, Channel and Power Controlling Software provided by the customer was used to control the operating channel as well as the output power level. The RF output power selection is for the setting of RF output expected by the customer and is going to be fixed on the firmware of the final end product.

### **Table for Parameters of Test Software Setting**

Frequency (MHz)	Power Setting	
2405	3	
2440	3	
2480	3	

## 4.2 Carrier Frequency and Channel

Channel	Freq. (MHz)	Channel	Freq. (MHz)
11	2405	19	2445
12	2410	20	2450
13	2415	21	2455
14	2420	22	2460
15	2425	23	2465
16	2430	24	2470
17	2435	25	2475
18	2440	26	2480



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## 4.3 Test Operation and Test Software

Setup for testing: Test samples are provided with an USB interface which makes it possible to control them through a test software installed on a notebook computer.

This software was running on the laptop computer connected to the EUT. It was used to enable the operation modes listed as below.

Test Software Radio Test Tool
-------------------------------

The samples were used as follows:

A003458670-013

A003458670-004

Full test was applied on all test modes, but only worst case was shown.

	Applicable To					
EUT Configure Mode	Antenna Port Conducted Measurement	Radiated Spurious Emissions above 1 GHz	Radiated Spurious Emissions below 1 GHz	Mains Conducted Emission	Description	
-	V	√	V	V	-	

#### Note:

- 1. The EUT had been pre-tested on the positioned of each 3 axis. The worst case was found when position on Z-plane.
- 2. "-" means no effect.

#### **Antenna Port Conducted Measurement**

- Pre-Scan full test was applied on all test modes, but only worst case was shown.
- Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Frequency (MHz)	Tested Frequency (MHz)	Date Rate (kbps)
-	2405 to 2480	2405, 2440, 2480	250

#### Radiated Spurious Emissions (Above 1 GHz)

- Pre-Scan full test was applied on all test modes, but only worst case was shown.
- Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode Available Frequency (MHz)		Tested Frequency (MHz)	Date Rate (kbps)							
-	2405 to 2480	2405, 2440, 2480	250							

#### Radiated Spurious Emissions (Below 1 GHz)

- Pre-Scan full test was applied on all test modes, but only worst case was shown.
- Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Frequency (MHz)	Tested Frequency (MHz)	Date Rate (kbps)
-	2405 to 2480	2440	250

#### **Mains Conducted Emission**

- Pre-Scan full test was applied on all test modes, but only worst case was shown.
- Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode		Tested Frequency (MHz)	Date Rate (kbps)
-	2405 to 2480	2440	250



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#### **Test Condition**

Test Item	Ambient Temperature	Relative Humidity	Tested by
Conducted Measurement	22.6-24.1 °C	56.4-59.1 %	Blake Wang
Radiated Spurious Emissions above 1 GHz	23.9-24.8 °C	53-54 %	Ivan Chiang
Radiated Spurious Emissions below 1 GHz	23.9-24.8 °C	53-54 %	Ivan Chiang
Mains Conducted Emission	21.1-24.9 °C	51.7-54.9 %	Ray Huang

## 4.4 Special Accessories and Auxiliary Equipment

The product has been tested together with the following additional accessories:

### **Accessory of EUT**

None

### **Support Unit**

	Support Unit										
No	Description	Brand	Model	S/N	Shielded	Ferrite Core (Qty)	Length (cm)	Remark			
Α	NB	FUJITSU	FMVS02001	N/A	-	-	-				
В	USB Cable	N/A	N/A	N/A	NO	NO	180	Radiated			
1	Power supply	GWINSTEK	GPS-3303	N/A	-	-	-	Radiated			
2	Cable	N/A	N/A	N/A	NO	NO	200				
Α	DC Cable	TUV JP	TUV JP-01	N/A	NO	NO	100	Mains			
1	Power supply	GWINSTEK	GPS-3303	N/A	-	-	-	Conducted			



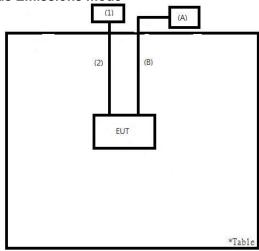
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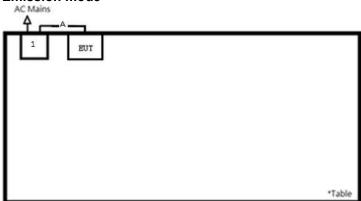
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## 4.5 Test Setup Diagram

<Radiated Spurious Emissions mode>



<Mains Conducted Emission mode>





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## 5. Test Results

## 5.1 Transmitter Requirement & Test Suites

### 5.1.1 Antenna Requirement

**Requirement** Use of approved antennas only

According to the manufacturer declaration, the EUT has an antenna with a directional gain of -0.2 dBi. The antenna is PCB antenna with no possibility of replacement with a non-approved antenna by the end-user. Therefore, the EUT is considered to comply with this provision. Refer to EUT photo for details.



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### 5.1.2 Peak Output Power

Limit 1 watt (30 dBm)

Kind of Test Site Shielded room

**Test Setup** 



#### **Test Instruments**

Kind of	Manufacturar	Type	C/NI	Calibration	Calibration	Test	Date
Equipment	Manufacturer	Type	Type S/N	Date	Due Date	From	Until
Power Meter	Anritsu	ML2495A	1901008	2023/3/17	2024/3/15	2023/5/19	2023/6/14
Power Sensor	Anritsu	MA2411B	1725269	2023/3/17	2024/3/15	2023/5/19	2023/6/14

#### **Test Procedures**

A peak power sensor was used on the output port of the EUT. A power meter was used to read the response of the peak power sensor. Record the power level.

Average power sensor was used to perform output power measurement, trigger and gating function of wide band power meter is enabled to measure max output power of TX on burst. Duty factor is not added to measured value.



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#### **Test Result**

#### **Peak Output Power**

Channel	Channel Frequency	Peak Outp	ut Power	Limit
	(MHz)	(dBm)	(mW)	(dBm)
Low Channel	2405	3.23	2.10	30
Middle Channel	2440	3.25	2.11	30
High Channel	2480	3.27	2.12	30

### **Average Power (For Reference)**

Channel	Channel Frequency	Average	e Power
	(MHz)	(dBm)	(mW)
Low Channel	2405	3.09	2.04
Middle Channel	2440	3.13	2.06
High Channel	2480	3.12	2.05



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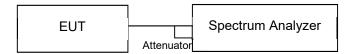
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### 5.1.3 6 dB Bandwidth and 99% Occupied Bandwidth

Limit The minimum 6 dB bandwidth shall be at least 500 kHz.

Kind of Test Site Shielded room

**Test Setup** 



#### **Test Instruments**

Kind of	Manufacturar	Appurpaturar Type 6		Manufacturer Type S/N Ca		Calibration	Calibration	Test	Date
Equipment	quipment   Manufacturer	туре	5/IV	Date	Due Date	From	Until		
Spectrum Analyzer	R&S	FSV	101512	2023/2/23	2024/2/22	2023/5/19	2023/6/14		

#### **Test Procedure**

- a. Set resolution bandwidth (RBW) = 100 kHz
- b. Set the video bandwidth (VBW)  $\geq$  3 x RBW, Detector = Peak.
- c. Trace mode = max hold.
- d. Sweep = auto couple.
- e. Measure the maximum width of the emission that is constrained by the frequencies associated with the two amplitude points (upper and lower) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.
- f. For 99% occupied bandwidth measurement, the transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with resolution bandwidth in the range of 1% to 5% of the anticipated emission bandwidth, and a video bandwidth at least 3x the resolution bandwidth and set the detector to PEAK. The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5% of the total mean power of a given emission.

#### **Test Results**

Please refer to Appendix A.



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### 5.1.4 Power Spectral Density

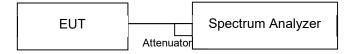
#### Limit

The power spectral density shall not be greater than 8 dBm in any 3 kHz band.

**Kind of Test Site** 

Shielded room

**Test Setup** 



#### **Test Instruments**

	Kind of	Manufacturar	Typo	S/N	Calibration	Calibration	Test	Date
-	Equipment	Manufacturer	Type	3/I <b>N</b>	Date	Due Date	From	Until
	Spectrum Analyzer	R&S	FSV	101512	2023/2/23	2024/2/22	2023/5/19	2023/6/14

#### **Test Procedure**

- a. Set analyzer center frequency to DTS channel center frequency.
- b. Set the span to 1.5 times the DTS bandwidth.
- c. Set the RBW to:  $3 \text{ kHz} \leq \text{RBW} \leq 100 \text{ kHz}$ .
- d. Set the VBW  $\geq$  3 × RBW.
- e. Detector = peak.
- f. Sweep time = auto couple.
- g. Trace mode = max hold.
- h. Allow trace to fully stabilize.
- i. Use the peak marker function to determine the maximum amplitude level within the RBW.

#### **Test Results**

Please refer to Appendix A.



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# 5.1.5 Conducted Spurious Emissions and Frequency Band Edges Measured in 100kHz Bandwidth

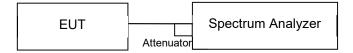
#### Limit

20dB (below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power.)

**Kind of Test Site** 

Shielded room

**Test Setup** 



#### **Test Instruments**

Kind of	Manufacturar	Type	S/N	Calibration Calib		Test	Date
Equipment	Manufacturer	Туре	3/IN	Date	Due Date	From	Until
Spectrum Analyzer	R&S	FSV	101512	2023/2/23	2024/2/22	2023/5/19	2023/6/14

#### **Test Procedure**

Measurement procedure REF

- 1. Set the RBW = 100 kHz.
- 2. Set the VBW ≥ 300 kHz.
- 3. Detector = peak.
- 4. Sweep time = auto couple.
- 5. Trace mode = max hold.
- 6. Allow trace to fully stabilize.
- Use the peak marker function to determine the maximum power level in any 100 kHz band segment within the fundamental EBW.

#### Measurement procedure OOBE

- 1. Set RBW = 100 kHz.
- 2. Set VBW ≥ 300 kHz.
- 3. Detector = peak.
- 4. Sweep = auto couple.
- 5. Trace Mode = max hold.
- 6. Allow trace to fully stabilize.
- 7. Use the peak marker function to determine the maximum amplitude level.

#### **Test Results**

Please refer to Appendix A.



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### 5.1.6 Radiated Spurious Emissions and Band Edges

#### Limit

Radiated emissions which fall in the restricted bands, as defined in §15.205(a), must comply with the radiated emission limits specified in §15.209(a).

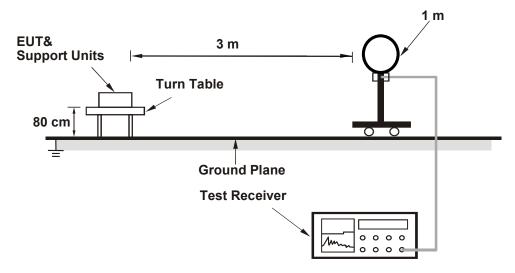
Emissions radiated outside the restricted and authorized frequency bands must either comply with the radiated emission limits specified for the restricted bands or in §15.247(d).

**Kind of Test Site** 

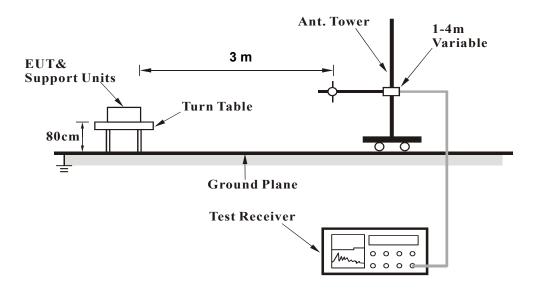
3m Semi-Anechoic Chamber

#### **Test Setup**

<Radiated Emissions below 30 MHz>



#### <Radiated Emissions 30 MHz to 1 GHz>



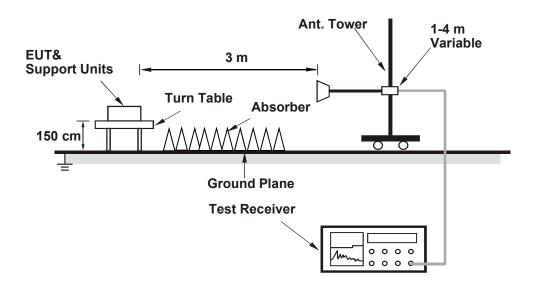


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#### <Radiated Emissions above 1 GHz>



For the actual test configuration, please refer to the attached file (Test Setup Photo).



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#### **Test Instruments**

Kind of Equipment	Manutacturer		S/N	Calibration Date	Calibration Due Date				
Above 1 GHz									
Signal Analyzer	R&S	FSV40	101508	2023/4/20	2024/4/18				
Horn Antenna	ETS-Lindgren	3117	00218929	2022/12/8	2023/12/7				
HF-AMP + AC source	EMCI	EMC051845SE	980633	2023/2/22	2024/2/21				
HF-AMP + AC source	EMCI	EMC184045SE	980657	2023/2/16	2024/2/15				
Horn Antenna	SCHWARZBECK	BBHA 9170	00218930	2022/12/8	2023/12/7				
Test Software	Audix E3	15914a_20191106 tuv PK-001087		N/A	N/A				
		30 MHz ~ 1 GHz							
Receiver	R&S	ESR7 102109		2023/2/24	2024/2/23				
Bilog Antenna	SCHWARZBECK	VULB-9168	VULB-9168 00951		2024/3/29				
LF-AMP	Agilent	8447D	2944A107722	2023/3/22	2024/3/20				
Test Software	Audix E3	15914a_20191106 tuv	PK-001087	N/A	N/A				
		Below 30 MHz							
Receiver	R&S	ESR7	102109	2023/2/24	2024/2/23				
Loop Antenna	SCHWARZBECK	FMZB 1519B	00215	2023/1/4	2024/1/3				
Test Software	Audix E3	15914a_20191106 tuv	PK-001087	N/A	N/A				



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#### **Test Procedures**

#### For Radiated Emissions below 30 MHz

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. Parallel (OPEN), perpendicular (CLOSE), and ground-parallel (GROUND) orientations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to Quasi-Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

#### Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 9 kHz at frequency below 30 MHz.
- 2. All modes of operation were investigated and the worst-case emissions are reported.

#### For Radiated Emissions above 30 MHz

- a. The EUT was placed on the top of a rotating table 0.8 meters (for 30 MHz ~ 1 GHz) / 1.5 meters (for above 1 GHz) above the ground at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.
- f. The test-receiver system was set to peak and average detected function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz. If the peak reading value also meets average limit, measurement with the average detector is unnecessary.

#### Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 kHz for Quasi-peak detection (QP) or Peak detection (PK) at frequency below 1 GHz.
- 2. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 3 MHz for Peak detection (PK) at frequency above 1 GHz.
- 3. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is ≥ 1/T (Duty cycle < 98 %) or 10 Hz (Duty cycle ≥ 98 %) for Average detection (AV) at frequency above 1 GHz.
- 4. All modes of operation were investigated and the worst-case emissions are reported.
- 5. The Radiated Emissions testing was performed in the X(E1), Y(H) and Z(E2) axis orientation. The worst-case Axis orientation is recorded in this test report.
- 6. The emission levels of other frequencies (including the 10th harmonic of the highest fundamental frequency) are very lower than the limit and are not shown in the test report.



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Test Results		
Factor (dB/m) = Antenna I Level (dBuV/m) = Reading	Factor (dB/m) + Cable Loss (dB) g (dBuV) + Factor (dB/m)	
Please refer to Appendix I	3.	



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### 5.2 Mains Emission

### 5.2.1 Mains Conducted Emission

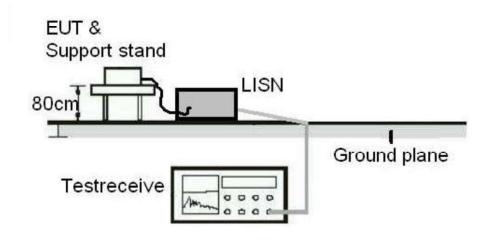
#### Limit

Mains Conducted Emission as defined in §15.207 must comply with the mains conducted emission limits.

**Kind of Test Site** 

Shielded room

**Test Setup** 



#### **Test Instruments**

Kind of Equipment	Manufacturer	Туре	S/N	Calibration Date	Calibration Due Date
Two-Line V- Network	Rohde & Schwarz	ENV216	101938	2022/9/22	2023/9/21
EMI Test Receiver	R&S	ESCI	100797	2022/6/19	2023/6/18



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#### **Test Procedures**

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 ohm/50 uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 150 kHz to 30 MHz was searched. Emission levels under (Limit 20 dB) was not recorded.

Note: The resolution bandwidth and video bandwidth of test receiver is 9 kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15 MHz – 30 MHz.

#### **Test Results**

Please refer to Appendix B.